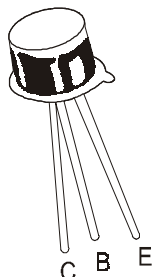


PNP SILICON PLANAR EPITAXIAL TRANSISTORS

BCY70 , 71, 72



TO-18
Metal Can Package

General Purpose Industrial Applications.

ABSOLUTE MAXIMUM RATINGS (Ta=25°C unless specified otherwise)

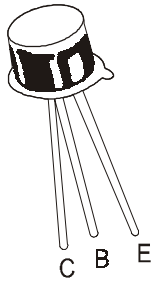
DESCRIPTION	SYMBOL	BCY70	BCY71	BCY72	UNIT
Collector Emitter Voltage	V_{CEO}	40	45	25	V
Collector Base Voltage	V_{CBO}	50	45	30	V
Emitter Base Voltage	V_{EBO}	5	5	5	V
Collector Current Continuous	I_C		200		mA
Collector Current Peak	I_{CM}		200		mA
Power Dissipation @Ta=25°C	P_D		350		mW
Derate Above 25°C			2		mW/°C
Operating Storage and Junction Temperature Range	T_{stg}	-65 to +200			°C

THERMAL RESISTANCE

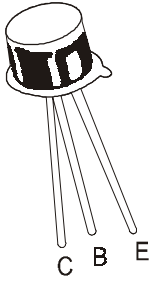
Junction to Ambient	$R_{th(j-a)}$	500	°C/W
Junction to Case	$R_{th(j-c)}$	150	°C/W

ELECTRICAL CHARACTERISTICS (Ta=25°C unless specified otherwise)

DESCRIPTION	SYMBOL	TEST CONDITION	VALUE			UNIT
			BCY70	BCY71	BCY72	
Collector Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	>40	>45	>25	V
Collector Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	>50	>45	>30	V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	>5	>5	>5	V
Collector Cut off Current	I_{CBO}	$V_{CB}=40V, I_E=0$	<10	<50		nA
		$V_{CB}=25V, I_E=0$			<50	nA
		$V_{CB}=40V, I_E=0$	<0.5	<2.0		μA
		$T_j = 100^\circ C$				
		$V_{CB}=25V, I_E=0$			<2	μA
		$T_j = 100^\circ C$				
		$V_{CB}=V_{CBO} \text{ MAX}, I_E=0$	<500	<500	<500	nA
Collector Cut off Current	I_{CEX}	$V_{CE} = 50V, V_{EB} = 3V$	<20			nA



DESCRIPTION		SYMBOL	TEST CONDITION	VALUE			UNIT	
				MIN	TYP	MAX		
Emitter Cut off Current		I _{EB0}	V _{EB} =4V, I _C =0			10	nA	
			V _{EB} =4V, I _C =0, T _j =100°C			2	μA	
			V _{EB} =54V, I _C =0			500	nA	
DC Current Gain		h _{FE}	I _C =10μA, V _{CE} =1V	60				
			I _C =100μA, V _{CE} =1V	80				
			I _C =1mA, V _{CE} =1V	100				
			BCY70	I _C =10mA, V _{CE} =1V	100			
			BCY71		100		400	
			I _C =50mA, V _{CE} =1V	45				
Collector Emitter Saturation Voltage		V _{CE(Sat)}	I _C =10mA, I _B =1mA			250	mV	
			I _C =50mA, I _B =5mA			500	mV	
Base Emitter Saturation Voltage		V _{BE(Sat)}	I _C =10mA, I _B =1mA	600		900	V	
			I _C =50mA, I _B =5mA			1.2	V	
<u>DYNAMIC CHARACTERISTICS</u>								
Transition Frequency		f _T	I _C =10mA, V _{CE} =20V f=100MHz	250			MHz	
			BCY71	I _C =100μA, V _{CE} =20V f=10.7MHz	15			MHz
Collector Capacitance		C _c	V _{CB} =10V, I _E =0, f=1MHz			6.0	pF	
Emitter Capacitance		C _e	V _{EB} =1.0V, f=1MHz, I _C =0			8.0	pF	
Noise Figure		NF	I _C =0.1mA, V _{CE} =5V					
			BCY70, 72	Rs=2KΩ, f=10Hz to 10KHz			6	dB
			BCY71				2	dB
Input Impedance		h _{ie}	I _C =10mA, V _{CE} =10V, f=1KHz		4.0		KΩ	
Reverse Voltage Transfer Ratio		h _{re}	I _C =10mA, V _{CE} =10V, f=1KHz		2.1		x10 ⁻⁴	
Small Signal Current Gain		h _{fe}	I _C =10mA, V _{CE} =10V, f=1KHz		325			
Out put Admittance		h _{oe}	I _C =10mA, V _{CE} =10V, f=1KHz		20		μmhos	

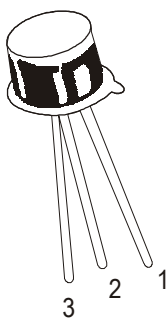
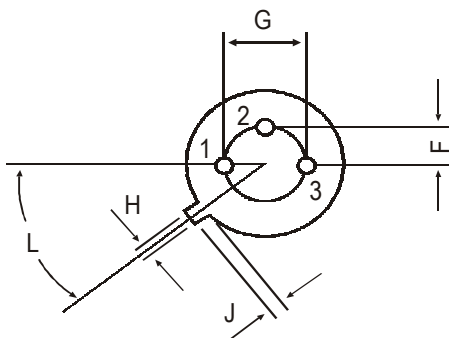
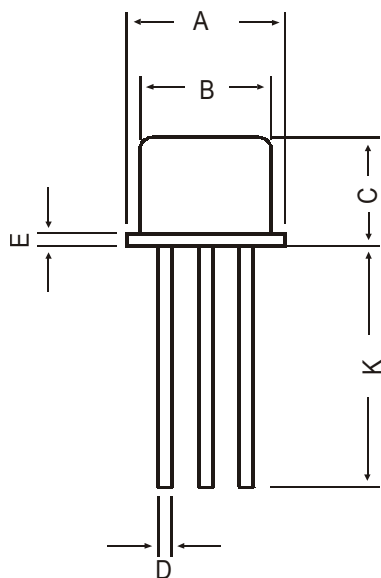


TO-18
Metal Can Package

DESCRIPTION	SYMBOL		TEST CONDITION	VALUE			UNIT
				MIN	TYP	MAX	
SWITCHING CHARACTERISTICS							
Delay time	t _d		I _C =10mA, I _{Bon} =I _{BOff} =1mA			35	ns
Rise time	t _r		I _C =10mA, I _{Bon} =I _{BOff} =1mA			35	ns
Turn on Time	t _{on}		I _C =10mA, I _{Bon} =I _{BOff} =1mA			65	
Storage time	t _s		I _C =10mA, I _{Bon} =I _{BOff} =1mA			350	ns
Fall time	t _f		I _C =10mA, I _{Bon} =I _{BOff} =1mA			80	ns
Turn Off Time	t _{off}		I _C =10mA, I _{Bon} =I _{BOff} =1mA			420	ns

TO-18
Metal Can Package

TO-18 Metal Can Package



- PIN CONFIGURATION
- 1. EMITTER
 - 2. BASE
 - 3. COLLECTOR

All dimensions in mm.

DIM	MIN	MAX
A	5.24	5.84
B	4.52	4.97
C	4.31	5.33
D	0.40	0.53
E	—	0.76
F	—	1.27
G	—	2.97
H	0.91	1.17
J	0.71	1.21
K	12.70	—
L	45 DEG	

Packing Detail

PACKAGE	STANDARD PACK		INNER CARTON BOX		OUTER CARTON BOX		
	Details	Net Weight/Qty	Size	Qty	Size	Qty	Gr Wt
TO-18	1K/polybag	350 gm/1K pcs	3" x 7.5" x 7.5"	5K	17" x 15" x 13.5"	80K	34 kgs

Disclaimer

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